LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION

DISCLOSURE STATEMENT

Atty. Docket No.: **P32.12-0019**

Appl. No.: 09/972,078

First Named Inventor:

Evren Eryurek et al.

Filing Date

Group Art:

October 5, 2001

2121

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Examiner Initial		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
N	AA	6,016,523	1/18/00	Zimmerman et al.	710	63	
7	AB	6,052,655	4/18/00	Kobayashi et al.	702	184	
	AC						
	AD					F	RECEIVED
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	AG					Tecl	nnology Center 2100
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FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Translation Yes No
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER: Toda Voeltz DATE CONSIDERED: 3/24/04

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APPLICANT'S INFORMATION OF DISCLOSURE STATEMENT	First Named Inventor:		
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Exam Init		Document No.	Date	Na	me	Class	Sub Class	Filing Date If Appropriate
TV	AA	3,618,592	11/9/71	Stewart et	al.	128	2.05	. 1
	AB	4,668,473	5/26/87	Agarwal		422	62	E M
	AC	4,720,806	1/19/88	Schippers e	t al.	-364-	551-	10 PC
	AD	4,736,763	4/12/88	Britton et	al.	137	10	8 20 1
	AE	5,089,979	2/18/92	McEachern e	t al.	-364 .	571.04	Ce 2 A
	AF	5,365,787	11/22/94	Hernandez e	t al.	73	660	Center Pro
	AG	5,436,705	7/25/95	Raj		355	246	250
	АН	5,526,293	6/11/96	Mozumder et	al.	_364	- 578 -	.0
\neg	AI	5,539,638	7/23/96	Keeler et al.		-364	_424.03	
	AJ	5,591,922	1/7/97	Segeral et al.		73	861.04	
	AK	5,633,809	5/27/97	Wissenbach et al.		- 364	510	
	AL	5,708,211	1/13/98	Jepson et a	1.	73	861.04	
	AM	5,710,370	1/20/98	Shanahan et	al.	73	1.35	
	AN	5,736,649	4/7/98	Kawasaki et	al.	73	861.23	
	AO	5,747,701	5/5/98	Marsh et al	•	73	861.23	
	AP	5,817,950	10/6/98	Wiklund et	al.	73	861.66	
	AQ	5,908,990	6/1/99	Cummings		73	861.22	
	AR	6,072,150	6/6/00	Sheffer		219	121.83	
	AS	6,112,131	8/29/00	Ghorashi et	al.	700	142	
	AT	6,119,529	9/19/00	DiMarco et al.		73	861.68	
1	AU	6,236,948	5/22/01	Eck et al.		702	45	
	AV	6,311,136	10/30/01	Henry et al.		702	45	
TV	AW	6,327,914	12/11/01	Dutton		73	861.356	
EXAMIN	NER:	Todd V	octo		DATE CONSID	ERED: 3	124/04	

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First Named Inventor:	:
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		Document No.	Date	Country	Class	Jy Center Class	2100 ranslation No
7	AN	03229124	11/10/91	Japan			X (abstract only)
7	AO	0 512 794 A2	5/5/92	EPO			Х

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N	AP	Journal of Intelligent Manufact tool condition monitoring syste	turing (1997) 8, 271-276 article entitled "On-line em with wavelet fuzzy neural network"
	AQ		
EXAMIN	NER:	Todal Vaette	DATE CONSIDERED: 3/24/04

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EXAMINER:	Todd Voeltz	DATE CONSIDERED: 3/24/04	

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FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR P32.12-0019

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FIRST Named Inventor:

Evren Eryurek et al.

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41	PA	4,249,164	2/3/81	Tivy	340	870.3	
7	PB	5,469,749	11/28/95	Shimada et al.	73	861.47	
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EXAMINER:	Tools Voetz	DATE CONSIDERED: 3 24/04



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T	AA	4,818,994	4/4/89	Orth	et al.	340	870	.21	
TV	AB	6,139,180	10/31/0	00 Ushe	r et al.	374	1	L	
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N	AN	IEEE Transac of the Coils	tions of an	on Ma Elec	gnetics tromagn	s, Vol. netic B	. 34, No. Flow Mete	5, r,"	Sep	tember jes 256	1998 , " 0 3-2566	Optical Design
7	AO	IEEE Transactions on Magnetics, Vol. Meter for Gases," pages 936-938				30, No.	2,	Mar	ch 1994	1, "Magne	tic Fluid Flow	
7	AP		IEEE Instrumentation and Measurement for primary transducer of electromag									
7	AQ	"Additional Echendu and						Sigr	nal	Analys	is," by 3	J.E. Amadi-
EXAMIN	NER:	Todal Va	ett	· · · · ·			DATE CO	NSID	ERE	D: 3	124/04	

FORM PTO-1449 Atty. Docket No.: Appl. No.: P32.12-0019 09/972,078 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION First Named Inventor: QISCLOSURE STATEMENT Evren Eryurek et al. Filing Date Group Art: October 5, 2001 2121

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77	AA	3,855,858	12/24/74	Cushing	73	194	
N	AB	5,388,465	2/14/95	Okaniwa et al.	73	861.17	
7/	AC	5,560,246	10/1/96	Bottinger et al.	73	. 861.15	
N	AD	6,014,902	1/18/00	Lewis et al.	73	861.12	
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	AI				Technology Cer	for 2100	
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		Document No.	Date	Country	Class	Sub Class	Translation Yes No
7	AM	11083575	3/26/99	Japan			(Abstract Only)
7	AN	60174915	9/9/85	Japan			(Abstract Only)
7	AO	59163520	9/14/84	Japan			(Abstract Only)

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1	AP	"Notification of Transmittal of the Declaration" for PCT/US01/40791.	International Search Report or the
7	AQ	"Notification of Transmittal of the Declaration" for PCT/US01/40782.	International Search Report or the
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EXAMIN	IER:	Todd Voelte	DATE CONSIDERED: 3(14/04

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Evren Eryurek et al.

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7	AA	3,849,637	11/19/74	Caruso et al.	235	151	
-1	AB	3,952,759	4/27/76	Ottenstein	137	12	e D
	AC	4,279,013	7/14/81	Cameron et al.	364	105	OCT O
	AD	4,417,312	11/22/83	Cronin et al.	364	510	1 () 1 ()
	AE	4,853,693	8/1/89	Eaton-Williams	340	588	2 2 II
	AF	5,434,774	7/18/95	Seberger	364	172	2 2002 Center 2100
	AG	5,608,650	3/4/97	McClendon et al.	364	510	220
	АН	5,682,317	10/28/97	Keeler et al.	364	431.03	.0
	AI	5,828,567	10/27/98	Eryurek et al.	364	184	
	AJ	5,936,514	8/10/99	Anderson et al.	340	310.01	
	AK	6,023,399	2/8/00	Kogure	361	23	
	AL	6,347,252	2/12/02	Behr et al.	700	3	
	AM	6,360,277	3/19/02	Ruckley et al.	709	250	
	AN	6,370,448	4/9/02	Eryurek	700	282	,
1/	AO	6,397,114	5/28/02	Eryurek et al.	700	51	
41	AP	6,425,038	7/23/02	Sprecher	710	269	
W	AQ		-				
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October 5, 2001

		Document No.	Date	Country	Class	Sub Class	Translation Yes No
7	BA	GB 2,347,232	8/30/00	United Kingdom	•		Х
	ВВ	GB 2,342,453	4/12/00	United Kingdom	DE		X
	BC	EP 1,022,626	7/26/00	EPO	111	CEIV	EU x
	BD	WO 98/39718	9/11/98	PCT WIPO	-00	T 0 2 20	02 ×
V.	BE	WO 99/19782	4/22/99	PCT WIPO	Tectino	OGY Cont	X
7	BF	WO 00/55700	9/21/00	PCT WIPO	. 5011110	ogy Cent	el 2100 <u>.</u>

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

7	BG	International Search Report for International Application No. PCT/US 02/14560, issued May 8, 2002. Report dated September 3, 2002.
N	ВН	International Search Report for International Application No. PCT/US 02/14934, issued May 8, 2002. Report dated August 28, 2002.
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Exam Init	iner ial	Document No.	Date	N	ame	Class	Sub Class	Filing Date If Appropriate
1	AA	Re.29,383	09/06/77	Gallatin e	et al.	137	14	
7	AB	3,096,434	07/02/63	King		235 ·	151	
7	AC	3,404,264	10/01/68	Kugler		235	194	
TV TV	AD	3,468,164	09/23/69	Sutherland	d	73	343 F	ECEIVED
1	AE	3,590,370	06/29/71	Fleischer		324	51	FC 1 2 2004
7	AF	3,688,190	08/29/72	Blum		324	61R	CC 1 3 2001
77	AG	3,691,842	09/19/72	Akeley		73	39 dech r	ology Center 2100
TV	АН	3,701,280	10/31/72	Stroman		73	194	,
7	AI	3,973,184	08/03/76	Raber		324	51	
TV	AJ	4,058,975	11/22/77	Gilbert et	al.	60	39.28	
77	AK	4,099,413	07/11/78	Ohte et al	Ohte et al.		359	
TV	AK	4,102,199	07/25/78	Talpouras		73	362	
77	AL	4,122,719	10/31/78	Carlson et	Carlson et al.		342	
N	AM	4,250,490	02/10/81	Dahlke		340	870.37	
7/	AN	4,337,516	06/29/82	Murphy et	al.	364	- 551-	*
TV	AO	4,517,468	05/14/85	Kemper et	al.	290	52	
1	AP	4,530,234	07/23/85	Cullick et	al.	73	53	
1/	AQ	4,571,689	02/18/86	Hildebrand	d et al.	- 364	-481	
_√	AR	4,635,214	01/06/87	Kasai et a	al.	-364-	-551 -	
TV	AS	4,642,782	02/10/87	Kemper et	al.	364	-550 -	
7	AT	4,644,479	02/17/87	Kemper et	al.	-364	- 550	
TV TV TV	AU	4,649,515	03/10/87	Thompson e	et al.	- 364 -	- 300	
7	AV	4,707,796	11/17/87	Calabro et al.		_364	- 552 -	
7	AW	4,736,367	05/05/88	Wroblewski et al.		370	85	
7	AX	4,777,585	10/11/88	Kokawa et al.		-364	-164	
17	AY	4,831,564	05/16/89	Suga		-364	-551_01	
EXAMIN	NER:	Todal	Joeth		DATE CONSID	ERED: 3	24/04	

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TV	ва	4,841,286	06/20/89	Kummer	340	653	·
TV	BB	4,873,655	10/10/89	Kondraske	-364-	-553-	·
TV	вс	4,907,167	03/06/90	Skeirik	-364	500	
7	BD	4,924,418	05/08/90	Backman et al.	_364	- 550	
7	BE	4,934,196	06/19/90	Romano	73	861.38	RECEIVED
TV	BF	4,939,753	07/03/90	Olson	375	107	DEC 1 3 2001
TV	BG	4,964,125	10/16/90	Kim .	371	15.1	,
TV	вн	4,988,990	01/29/91	Warrior	340	25.5 Te	hnology Center 2100
1	BI	4,992,965	02/12/91	Holter et al.	-364→	+551.0I	
TV	ВJ	5,005,142	04/02/91	Lipchak et al.	-364	550-	
TV	вк	5,043,862	08/27/91	Takahashi et al.	-364	-162	
TV	BL	5,053,815	10/01/91	Wendell	355	208	
7	ВМ	5,067,099	11/19/91	McCown et al.	-364	-550	
7777	BN	5,081,598	01/14/92	Bellows et al.	-364 -	- 550	
7	во	5,089,984	02/18/92	Struger et al.	-395	650	
7	BP	5,098,197	03/24/92	Shepard et al.	374	120	
7	BQ	5,099,436	03/24/92	McCown et al.	-364	-550	
7	BR	5,103,409	04/07/92	Shimizu et al.	-364	-556	
7	BS	5,111,531	05/05/92	Grayson et al.	-395 -	-23-	
TV	ВТ	5,121,467	06/09/92	Skeirik	- 39 5		
77	BU	5,122,794	06/16/92	Warrior	340	825.2	
7	BV	5,122,976	06/16/92	Bellows et al.	_364_	-550-	
7	BW	5,130,936	07/14/92	Sheppard et al.	-364	-551.01	
7	BX	5,134,574	07/28/92	Beaverstock et al.	-364	551_01	
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TV	CA	5,137,370	08/11/92	McCullock et al.	374	173	
TV	СВ	5,142,612	08/25/92	Skeirik	395	11_	
7	СС	5,143,452	09/01/92	Maxedon et al.	374	170	
TV	CD	5,148,378	09/15/92	Shibayama et al.	-364	551.07	RECENT
TV.	CE	5,167,009	11/24/92	Skeirik	-395	-27-	LICEIVED
7	CF.	5,175,678	12/29/92	Frerichs et al.	-364	-148	DEC 1 3 2001
TV.	CG	5,193,143	03/09/93	Kaemmerer et al.	-395	-51- 7	
TV	СН	5,197,114	03/23/93	Skeirik	-395	-22	echnology Center 2100
TV.	CI	5,197,328	03/30/93	Fitzgerald	73	168	
TV	CJ	5,212,765	05/18/93	Skeirik	-395	-11-	
N	CK	5,214,582	05/25/93	Gray	364	424.03	
7	CL	5,224,203	06/29/93	Skeirik	395	22-	
7	СМ	5,228,780	07/20/93	Shepard et al.	374	175	
7	CN	5,235,527	08/10/93	Ogawa et al.	- 364	-571.05	-
_TV	СО	5,265,031	11/23/93	Malczewski	364	-497-	
7	CP	5,265,222	11/23/93	Nishiya et al.	395	-3-	
7	CQ	5,274,572	12/28/93	O'Neill et al.	364	-550 '	
TV	CR	5,282,131	01/25/94	Rudd et al.	-364	-164	
7	CS	5,282,261	01/25/94	Skeirik	-395-	-22	
7	СТ	5,293,585	03/08/94	Morita	-395 -	-52	
N	CÜ	5,303,181	04/12/94	Stockton	365	96	
7	CV	5,305,230	04/19/94	Matsumoto et al.	-364	495	
7	CW	5,311,421	05/10/94	Nomura et al.	-364	157	
\mathcal{N}	CX	5,317,520	05/31/94	Castle	-364	- 402	
EXAMIN	NER:	Tode	Voelte	DATE CONSI	DERED:	3/24/04	

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Filing Date Group Art: 2121

October 5, 2001

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TV	DA	5,327,357	07/05/94	Feinstein et	t al.	364	-502-	
	DB	5,333,240	07/26/94	Matsumoto et	t al.	- 395	_23	
	DC	5,349,541	09/20/94	Alexandro,	Jr. et al.	- 364	-578	
	DD	5,357,449	10/18/94	Oh		-36 4	-551.01	
	DE	5,361,628	11/08/94	Marko et al.	•	73	116	
	DF	5,365,423	11/15/94	Chand		-364	-140-	
	DG	5,367,612	11/22/94	Bozich et al	l.	- 395	-22	
	DH	5,384,699	01/24/95	Levy et al.		-364	, 413.13	RECEIVED
	DI	5,386,373	01/31/95	Keeler et al	l.	-364	- 577	DEC 1 2 222
	DJ	5,394,341	02/28/95	Kepner		-364	_551_01	PEG T 3 5001
	DK	5,394,543	02/28/95	Hill et al.		-395 .	- 575 Tec	hnology Center 2100
	DL	5,404,064	04/04/95	Mermelstein	et al.	310	319	
	DM	5,408,406	04/18/95	Mathur et al	L.	-364	-163	
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	DS	5,442,639	08/15/95	Crowder et a	Crowder et al.		20.1	
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	DU	5,469,070	11/21/95	Koluvek		324	713	
	DV	5,469,156	11/21/95	Kogura		340	870.38	
V	DW	5,469,735	11/28/95	Watanabe		73	118.1	
TV	DX	5,481,199	01/02/96	Anderson et	al.	324	705	
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	EE	5,489,831	02/06/96	Harris	318	701	
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Evren Eryurek et al.

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Sheet 17 of 19 Appl. No.: 09/972,078

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First Named Inventor:

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